

BLG3040 IGBT

COLLECTOR

EMITTER

TO-252

1. Description > Advantages

BLG3040 is obtained by advanced ignition IGBTs technology which reduce the conduction loss, enhance the SCIS capability. Internally integrated diodes can provide the voltage clamping without the need for external components. The IGBT is suitable device for automotive ignition circuits, specifically as a coil driver.

> Key Characteristics

Value	Unit
425	V
1.25	V
300	mJ
4	kV
	425 1.25

> Features

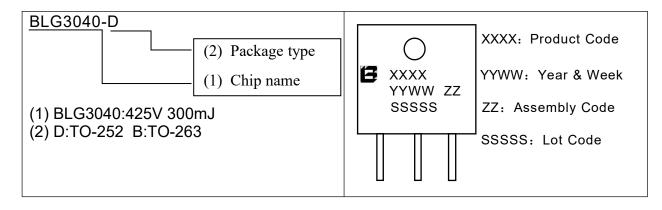
- Low V_{CEsat}
- **High SCIS Energy**
- Logic Level Gate Drive
- AEC-Q101 Qualified > Applications
- Automotive ignition Coil Driver Circuits
- **Coil-On Plug Application**

Ordering Informations

Ordering infor	mations		
Ordering Codes	Package	Product Code	Packing
BLG3040-D	TO-252	G3040	Tape Reel
BLG3040-B	TO-263	G3040	Tape Reel

GATE O

TO-263





2. Absolute Ratings

at T_c = 25°C, unless otherwise specified

Symbol	Parameter	Rating	Units
V _{CES}	Collector-Emitter Voltage (I _C =2mA, R _G =1k Ω)	455	V
V _{ECS}	Emitter to Collector Voltage (Ic=10mA)	24	V
E	SCIS Energy@ T _J =25 °C, I _{SCIS} =14.2A	300	mJ
Escis	SCIS Energy@ T _J =150 °C, I _{SCIS} =10.6A	170	mJ
	Collector Current @T _c =25 °C	21	А
Ic	Collector Current @Tc=100 °C	17	А
ESD	Electrostatic Discharge Voltage (HBM) at 100pF,1500Ω	4	kV
V _{GEM}	Gate- Emitter Voltage Continuous	±10	V
PD	Power Dissipation @TC = 25 °C	150	W
T _J , T _{stg}	Operating Junction and Storage Temperature Range	-40 to 175	°C
TL	Maximum Temperature for Soldering	260	°C

3. Thermal Characteristics

Symbol	Parameter	Package	RATINGS	Units
Rejc	Junction-to-Case	TO-252/TO-263	1.0	°C /W

4. Electrical Characteristics

at T_C = 25°C, unless otherwise specified

OFF Characteristics						
Symbol	Parameter Test Values					
Symbol	Falameter	Conditions	Min.	Тур.	Max.	- Units
BV _{CER}	Collector to Emitter Breakdown Voltage	V_{GE} =0V, I _C =2mA, R _G =1kΩ	395	425	455	V
BV _{CES}	Collector to Emitter Breakdown Voltage	V_{GE} =0V, I _C =10mA, R _G =0 Ω	410	440	470	V
BV _{ECS}	Emitter to Collector Breakdown Voltage	V_{GE} =0V, I _C =-75mA	30			V
BV _{GES}	Gate to Emitter Breakdown Voltage	I _{GES} =±2mA	±12	±14		V
lass	Collector to Emitter	V _{CE} =250V, R _G =1kΩ, T _J =25°C			25	μA
ICER	Leakage Current	V _{CE} =250V, R _G =1kΩ, T _J =150°C			1	mA
	Emitter to Collector	V_{EC} =24V, T _J =25°C			1	mA
I _{ECS}	Leakage Current	V _{EC} =24V, T _J =150°C			40	mA



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IGBT

R ₁	Series Gate Resistance		70		Ω
R ₂	Gate to Emitter Resistance	10		26	kΩ

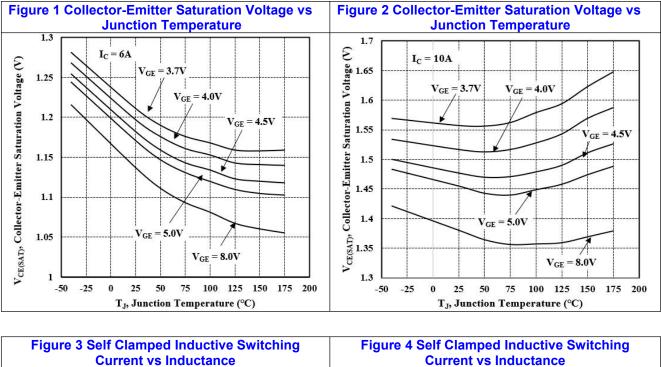
ON Characteristics						
Symbol	Parameter	Test Conditions		Values	;	Units
Cymbol	1 diameter		Min.	Тур.	Max.	Onits
V _{CE(sat)}	Collector-Emitter Saturation Voltage	V _{GE} =4V, I _C =6A, T _J =25°C		1.20	1.60	V
V _{CE(sat)}	Collector-Emitter Saturation Voltage	V _{GE} =4.5V,I _C =10A,T _J =175°C		1.52	1.80	V
V _{CE(sat)}	Collector-Emitter Saturation Voltage	V _{GE} =4.5V,I _C =15A,T _J =175°C		1.90	2.20	V
$V_{GE(TH)} \begin{array}{c c} Gate Threshold \\ Voltage \end{array} V_{CE} = V_{GE}, I_C = 1mA \qquad 1.30 2.20 V$						
Pulse width	n tp≤300μs, δ≤2%					

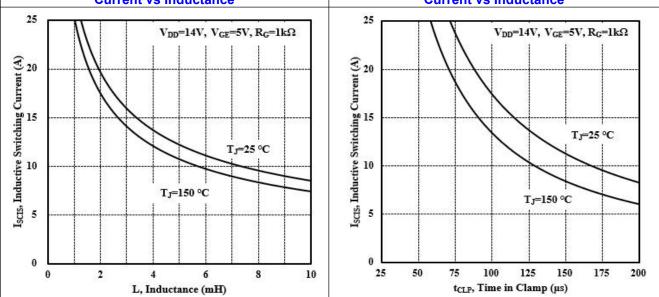
Dynamic Characteristics						
Symbol	Parameter	Test Conditions		Values		Units
Symbol	Farameter		Min.	Тур.	Max.	Units
Ciss	Input Capacitance	$\gamma = 0 \gamma$		1250		
Coss	Output Capacitance	- V _{GE} = 0V V _{CE} = 25V		69		pF
Crss	Reverse Transfer Capacitance	f=1.0MHz		15		
Qg	Total Gate Charge	I_C =10A, V_{CE} =12V, V_{GE} =5V		7.2		nC

Switching Characteristics							
Symbol	Parameter	Test Conditions		Values		Units	
Symbol	Falameter		Min.	Тур.	Max.	Units	
t _{d(ON)}	Turn-on Delay Time	V _{CE} = 14V, RL=1Ω, V _{GE} = 5V, R _G =1kΩ,		0.85	4		
tr	Rise Time	$V_{GE} = 5V, R_G = 1R\Omega, T_J=25^{\circ}C$		2.50	7		
t _{d(OFF)}	Turn-Off Delay Time	V _{CE} = 300V, L=500μH, V _{GE} = 5V, R _G =1kΩ,		4.40	15	μs	
t _f	Fall Time	V _{GE} = 5V, K _G = 1K _Ω , T _J =25°C		1.90	15		



5. Characteristics Curves

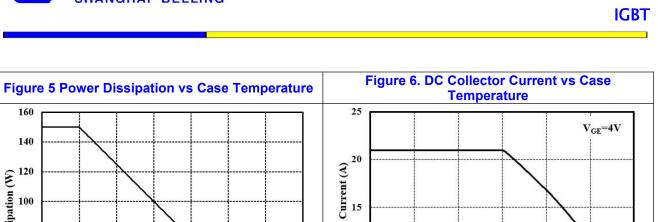




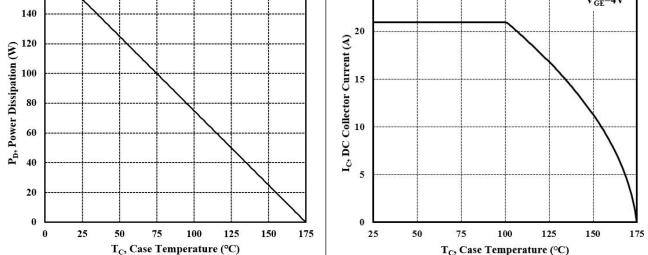
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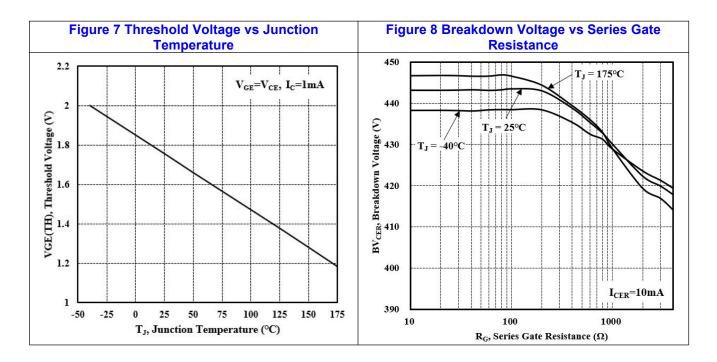


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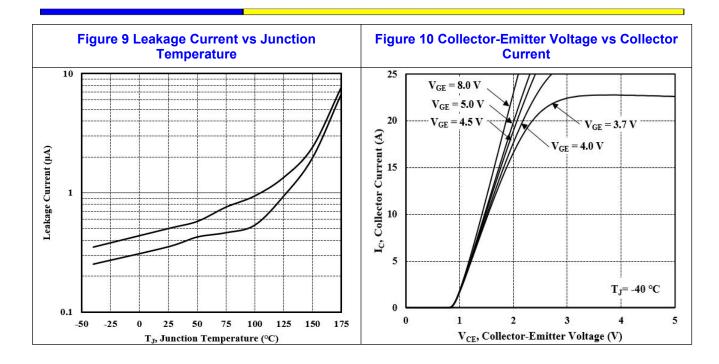


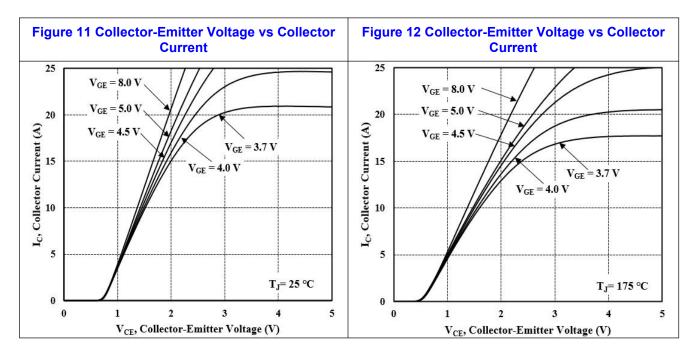


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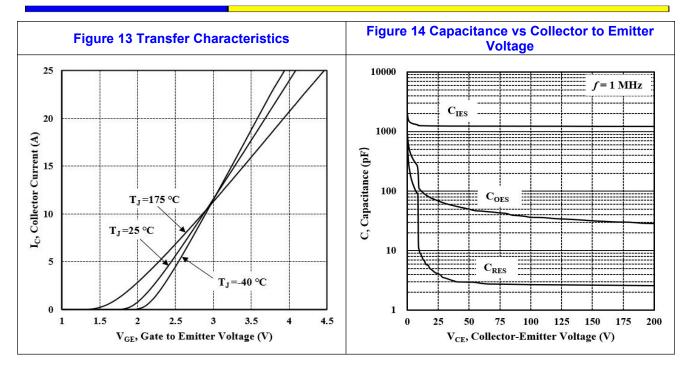


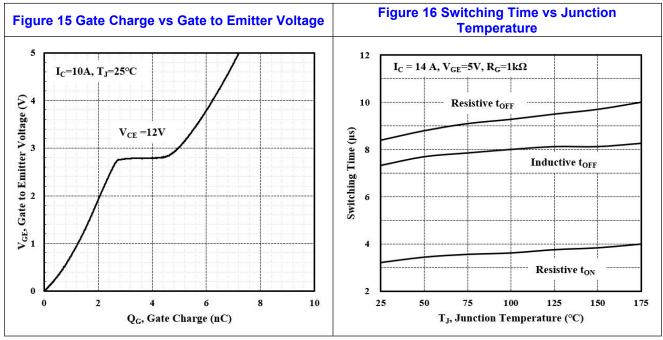




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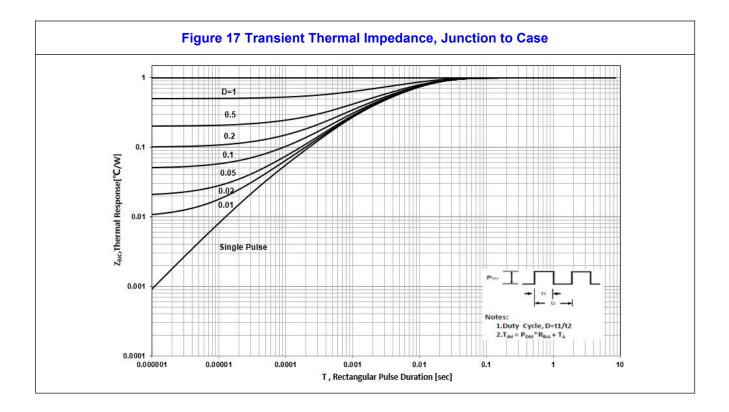




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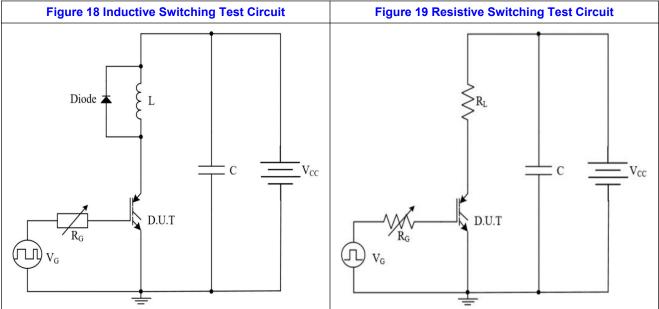


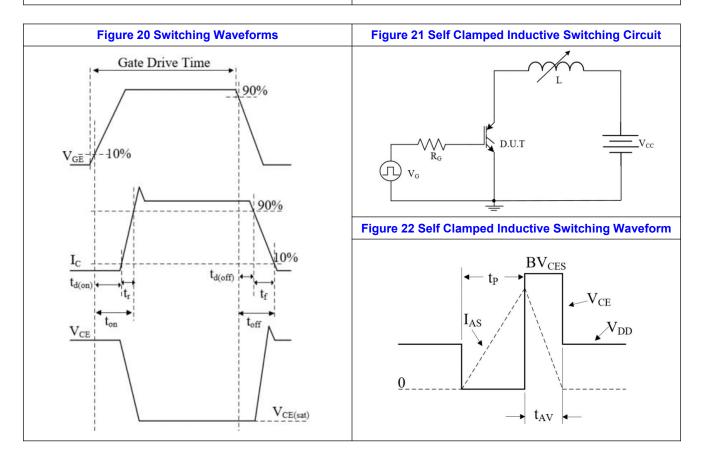






6. Test Circuit and Waveform





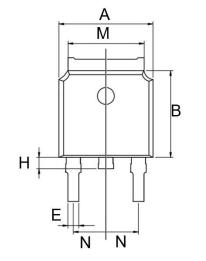
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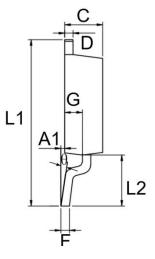
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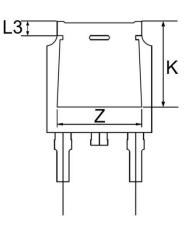
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7. Package Description



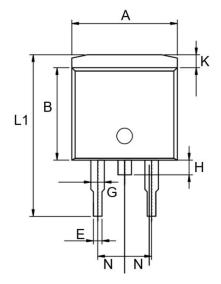


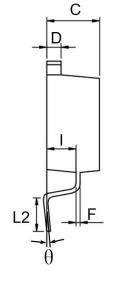


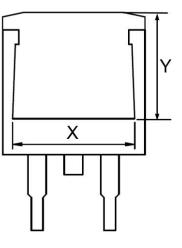
TO-252 Package

140.000	Values(mm)			
Items	MIN	NOM	MAX	
А	6.45	6.60	6.75	
A1	0.05	0.10	0.20	
В	5.95	6.10	6.25	
С	2.15	2.30	2.45	
D	0.40	0.50	0.60	
E	0.66	0.76	0.86	
F	0.40	0.500	0.6	
G	0.91	1.07	1.22	
Н	0.60	0.80	1.00	
K		3.80		
L1	9.80	10.10	10.40	
L2	2.80	3.10	3.40	
L3	0.70	0.80	1.00	
Н	0.60	0.80	1.00	
М	5.12	5.32	5.52	
2N		4.57		
Z		4.80		
θ	0°	-	8°	









TO-263 Package

Items	Values (mm)		
	MIN	NOM	MAX
А	9.85	10.15	10.45
В	8.46	8.66	8.86
С	4.50	4.70	4.90
D	1.17	1.27	1.37
E	0.72	0.82	0.92
F	0.28	0.38	0.48
G	1.12	1.27	1.42
Н	1.20	1.40	1.60
I	2.45	2.60	2.70
К	1.01	1.23	1.50
L1	14.75	15.15	15.55
L2	2.30	2.55	2.80
2N	5.08		
Х	7.90	8.10	8.40
Y	5.50	5.70	5.90
θ	0°	7°	8°





Revision History:

BLG3040 Revision: 2024-07-11, Rev. 2.2(A)

Previous Revision

Revision	Date	Revision Date Subjects (major changes since last revision)	
1.0	2019-10-21	-	
1.1	2021-07-06	 Some key Information has been added below. (1) Switching characteristics. (2) Self-clamped Inductive switching current curves. (3) Breakdown voltage curves have been added. 	
2.0	2022-03-31	 The major changes are as follow. (1) In Section 4, the data of ON characteristics and dynamic characteristics have been updated. (2) In Section 5, P_D vs T_J curve and I_{SCIS} vs T_{CLP} curve have been added. (3) In Section 5, all figures of characteristics curves have been reformatted and adjusted in sequence. (4) In Section 6, all figures of test circuit and typical waveform have been redrawn and rearranged. (5) In Section 7, all diagrams of different package and some dimensions information have been redrawn and updated. (6) Formatting and spelling errors in this document have been corrected. (7) Revision history is firstly added in the BLG3040 datasheet . 	
2.1	2024-01-31	 The major changes are as follow. (1) In Section 4, the data of OFF characteristics has been updated. (2) the CONTACT has been updated. (3) The catalog index has been updated. 	
2.2	2024-07-11	 The major changes are as follow. (1) Corrected the value of V_{CES} on the homepage and marked '_{Typ.'}. (2) Updated the testing conditions and values for V_{CES} in '2. Absolute Ratings' on page 2. 	

We Listen to Your Comments

If there is any information within this document that you feel is wrong, unclear, or missing at all, please contact us.

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NOTE:

- 1. Any use beyond the maximum ratings of the device in performance may cause damage to the device or even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when designing circuit.
- 2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
- 3. Semiconductor device is sensitive to the ESD, it is necessary to protect the device from being damaged by the ESD when using it.
- 4. Shanghai Belling reserves the right to make changes in this specification sheet and is subject to change without prior notice.

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